

Notice of References Cited	Application/Control No. 10/565,320	Applicant(s)/Patent Under Reexamination MEYER ET AL.	
	Examiner RENEE DANEGA	Art Unit 3736	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0108451	08-2002	May et al.	73/861.63
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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